



PATENT

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Michael C. Adler, et. al.

Serial No.: 09/332,263

Art Unit: 2163

Filed: June 11, 1999

Examiner: unassigned

Title: PROFILING PROGRAM EXECUTION BY DENSE TRACE PROFILING  
STATISTICAL PROFILING

TC 2100 CSO  
STATUS INQUIRY  
RECEIVED

COMMISSIONER FOR PATENTS  
Washington D.C. 20231

FEB 19 2002

REQUEST FOR CONFIRMATION NUMBER

Initials: 

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Technology Center 2100

It is believed that no fee is due. If any fee is required, kindly charge any additional fee, or credit any surplus, to Deposit Account 50-0675, Order No. 5231.8-4015.

Respectfully submitted,

SCHULTE ROTH & ZABEL

Dated: January 28, 2002

By: 

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I certify that this correspondence, along with any documents referred to therein, is being deposited with the United States Postal Service on January 28, 2002 as First Class Mail in an envelope with sufficient postage addressed to The Commissioner for Patents, Washington D.C. 20231.

